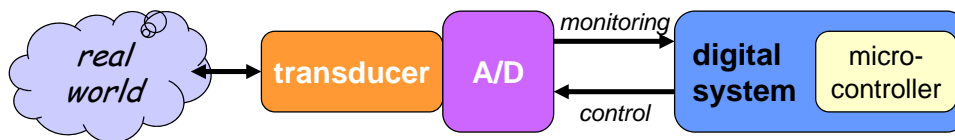


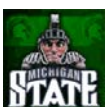
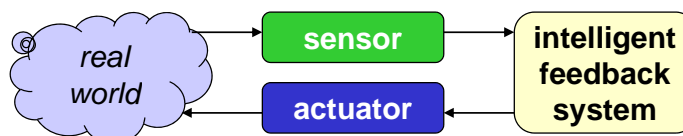
Analog-to-Digital Converters

- Terminology
 - analog-to-digital converter = ADC = A/D = AtoD
- Function
 - transform an analog signal into a digital signal for use (calculation, storage, decision making) in an digital system e.g., a microcontroller
- Motivation
 - the real world is analog
 - A/D needed to interface real world to digital systems
 - monitoring of real world events/phenomena
 - electronic intelligent feedback control of real world



Transducers

- Transducer
 - a device that converts a primary form of energy into a corresponding signal with a different energy form
 - Primary Energy Forms:
 - take form of a **sensor** or an **actuator**
- Sensor (e.g., thermometer)
 - a device that detects/measures a signal or stimulus
 - acquires information from the "real world"
- Actuator (e.g., heater)
 - a device that generates a signal or stimulus



Common Transducers

- Conventional Transducers

large, but generally reliable; based on older technology

- thermocouple: temperature difference
- compass (magnetic): direction

- Microelectronic Sensors

millimeter sized; highly sensitive; less robust

- photodiode/phototransistor: photon energy (light)
 - infrared detectors, proximity/intrusion alarms
- piezoresistive pressure sensor: air/fluid pressure
- microaccelerometers: vibration, Δ -velocity (car crash)
- chemical sensors: O₂, CO₂, Cl, Nitrates (explosives)
- DNA arrays: match DNA sequences

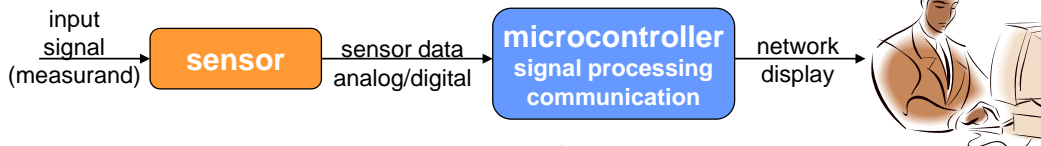


Sensor Systems

Generally interested in *electronic sensor*

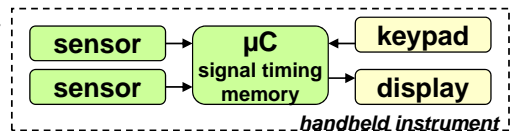
- convert desired parameter into electrically measurable signal

- Typical Electronic Sensor System

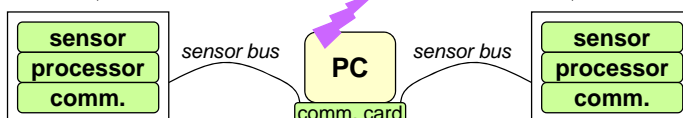
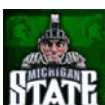
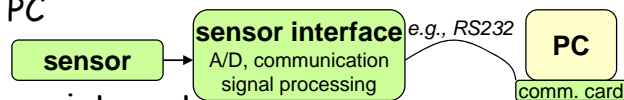


- Example Sensor System Configurations

- digital sensor within an instrument
 - microcontroller
 - signal timing, data storage
- analog sensor analyzed by a PC

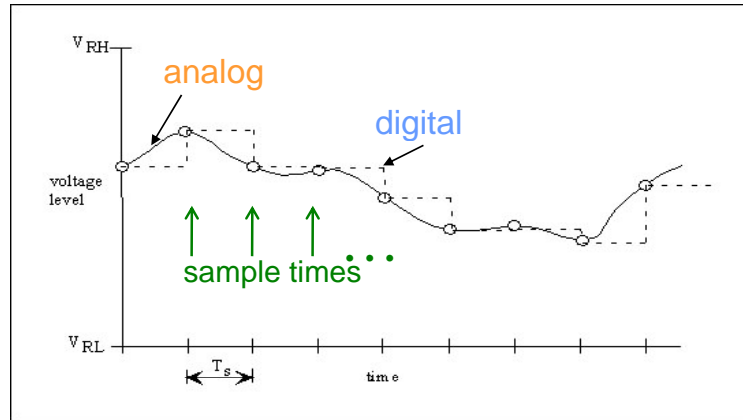


- multiple sensors displayed over internet



A/D Basic Concepts

- Analog signal characteristics
 - maximum voltage
 - minimum voltage
 - voltage sensitivity
 - frequency components
- Digital sample feature
 - voltage reference high:

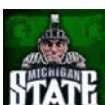
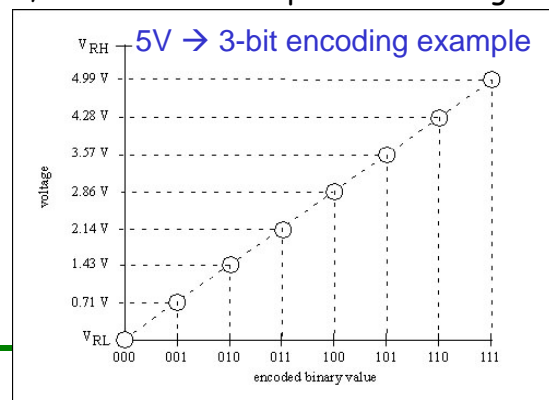


A/D Conversion Process

- Sampling rate
 - What is sampling? strobe light example
 - Nyquist criterion: minimum sample frequency (f_s) should be twice the highest frequency content (f_h) of the sampled signal
 - Time interval between samples:
 - Anti-aliasing filter: use LPF with
 - Example: sample human voice at 8KHz, use 4KHz LPF to prevent aliasing

- Encoding
 - Provides unique binary code for every discrete voltage step between V_{RH} and V_{RL}
 - $n = \#steps = 2^b$, $b = \#bits$

EXAMPLE: What voltage is encoded by 101?



A/D Conversion Process

- Quantization: number of discrete levels the analog signal is divided into between V_{RH} and V_{RL}
 - #steps = 2^b
 - more levels (steps) \rightarrow better representation of sampled signal
- Resolution: voltage per step
 - Resolution = $(V_{RH} - V_{RL})/\text{number of steps} =$

EXAMPLE: $V_{RH} = 5\text{ V}$, $V_{RL} = 0\text{ V}$, quantization = 256 levels
bits = ?

Resolution = ?

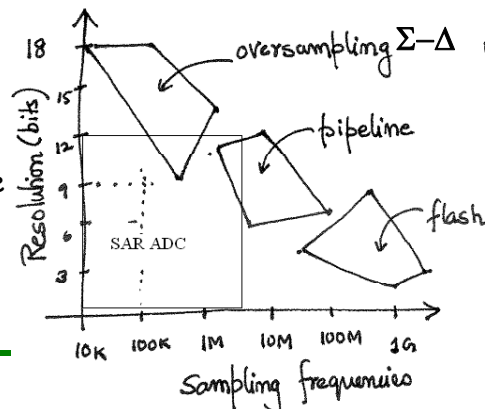
 - Analog value:
- Data rate: # of A/D result bits per second, $d = f_s \times b$



Analog-to-Digital System.7

Common A/D Architectures/Structures

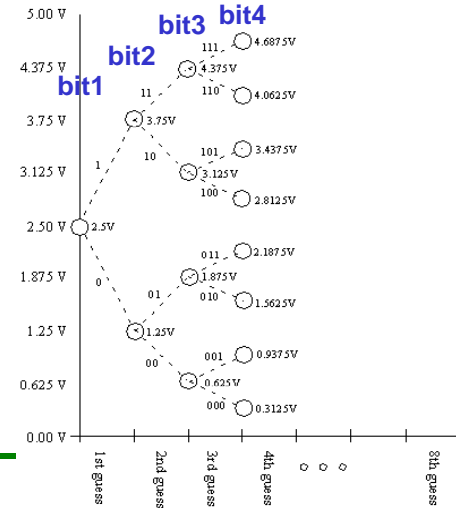
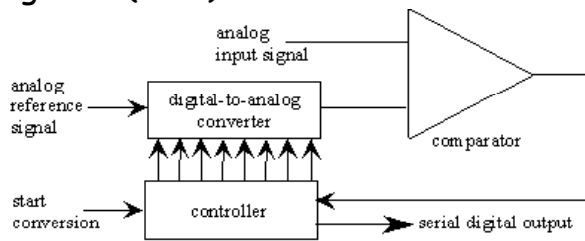
- Flash: bank of comparators sample input signal in parallel
 - very fast (GHz+), size limits resolution: number of comparators needed, $2^N - 1$, doubles with each additional bit
- Integrating: measures the time it takes to integrate a reference signal to match input value
 - common in digital voltmeters because of linearity and flexibility
- Sigma-Delta: oversamples signal by a large factor and filters the desired signal band
 - slow but high resolution
- Successive-approximation: constantly compares input voltage to reference value; reference value moves closer to input value each cycle
 - #cycles = #bits resolution
- Pipelined: combines successive approximation and flash
 - fast, high resolution, small die (chip) size



Example: Best choice for:
High speed?
High resolution?

Successive Approximation A/D

- Constantly compares input voltage to reference value set by an internal DAC
- DAC value cuts voltage range in half each cycle to approach input value
 - each cycle → one more bit of resolution
- Final binary value stored in a successive approximation register (SAR)



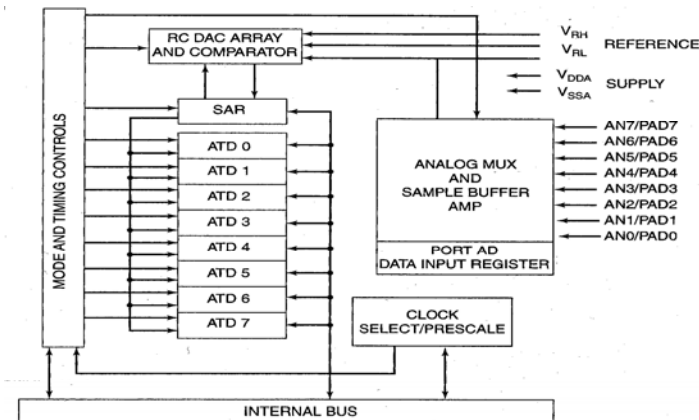
Example: What is 3b ADC result for 1.75V?

- bit 1?
- bit 2?
- bit 3?



68HC12 ATD System

- Eight ATD analog inputs on
- Inputs fed to analog multiplexer
- Single signal fed to successive approximation converter
- Initiate conversion by writing to control register
- Upon conversion complete, flags set in status registers
- Results available in results register



HC12 ATD Registers

- Control registers - configures ATD for specific operation (ATDCTL0 - ATDCTL5)
 - used to tailor an ATD conversion sequence
- Status registers - two-byte register containing ATD status flags (ATDSTAT)
- Result registers - contains binary weighted result after conversion (ADROH - ADR7H)
- Test registers - used in special modes



ATD Control Registers

- **ATDCTL2:** memory address: **\$0062**
 - ADPU: "on/off" switch
 - 0: off, 1: on (0 after processor reset)
 - must wait 100 us after "on" prior to using ATD
 - AFFC: ATD Fast Flag Clear
 - 0: normal clearing - write to ATDCTL5
 - 1: fast clearing - cleared when first result register read

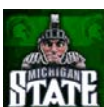
Register: Analog-to-Digital Converter Control Register 2 (ATDCTL2) Address: \$0062							
7	6	5	4	3	2	1	0
ADPU	AFFC	AWAI	0	0	0	ASCIE	ASCIF
Reset: 0	0	0	0	0	0	0	0

- **ATDCTL4:** memory address: **\$0064**
 - controls sample timing for conversion sequence

Register: Analog-to-Digital Converter Control Register 4 (ATDCTL4) Address: \$0064							
7	6	5	4	3	2	1	0
0	SMP1	SMP0	PRS4	PRS3	PRS2	PRS1	PRSO
Reset: 0	0	0	0	0	0	0	0

SMP1	SMP2	Final Sample Time	Total 8-bit Conversion Time
0	0	2 ATD clock periods	18 ATD clock periods
0	1	4 ATD clock periods	20 ATD clock periods
1	0	8 ATD clock periods	24 ATD clock periods
1	1	16 ATD clock periods	32 ATD clock periods

Example: What is the max ATD sampling frequency?

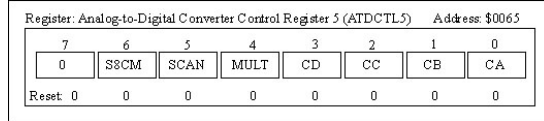


ATD Control Registers

- **ATDCTL5**: memory address: \$0065

- configure conversion mode for ATD

- **S8CM**: select 8 channel mode
 - 0: four, 1: eight conversions
- **SCAN**: enable continuous scan
 - 0: single 1: continuous conversion
- **MULT**: enable multiple channel conversion
 - 0: single channel, 1: multiple channels
- **CD,CC,CB,CA**: set channels for conversion



Example: How many different input channels can be selected?

S8CM	CD	CC	CB	CA	Channel Signal	Result in ADRx if MULT = 1
0	0	0	0	0	AN0	ADR0
0	0	0	0	1	AN1	ADR1
0	0	0	1	0	AN2	ADR2
0	0	0	1	1	AN3	ADR3
0	0	1	0	0	AN4	ADR0
0	0	1	0	1	AN5	ADR1
0	0	1	1	0	AN6	ADR2
0	0	1	1	1	AN7	ADR3
0	1	0	0	0	Reserved	ADR0
0	1	0	0	1	Reserved	ADR1
0	1	0	1	0	Reserved	ADR2
0	1	0	1	1	Reserved	ADR3
0	1	1	0	0	V _{RH}	ADR0
0	1	1	0	1	V _{RL}	ADR1
0	1	1	1	0	(V _{RH} + V _{RL})/2	ADR2
0	1	1	1	1	Test/reserved	ADR3
1	0	0	0	0	AN0	ADR0
1	0	0	0	1	AN1	ADR1
1	0	0	1	0	AN2	ADR2
1	0	0	1	1	AN3	ADR3
1	0	1	0	0	AN4	ADR4
1	0	1	0	1	AN5	ADR5
1	0	1	1	0	AN6	ADR6
1	0	1	1	1	AN7	ADR7
1	1	0	0	0	Reserved	ADR0
1	1	0	0	1	Reserved	ADR1
1	1	0	1	0	Reserved	ADR2
1	1	0	1	1	Reserved	ADR3
1	1	1	0	0	V _{RH}	ADR4
1	1	1	0	1	V _{RL}	ADR5
1	1	1	1	0	(V _{RH} + V _{RL})/2	ADR6
1	1	1	1	1	Test/reserved	ADR7

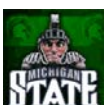
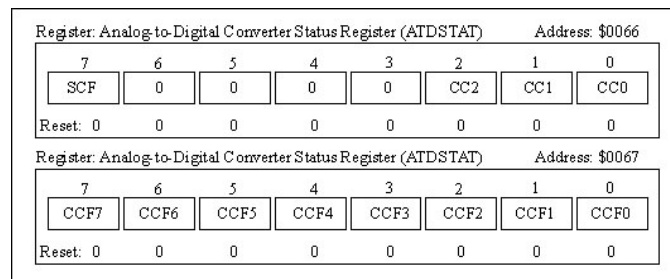
Shaded bits are "don't care" if MULT = 1 and the entire block of four or eight channels makes up a conversion sequence. When MULT = 0, all four bits (CD, CC, CB, and CA) must be specified and a conversion sequence consists of four or eight consecutive conversions of the single specified channel.



ATD Status Registers

- **ATDSTAT**: memory address: \$0066, \$0067 two bytes

- **SCF**: Sequence Complete Flag
 - indicates specified conversion sequence is complete
- **CCx**:
 - indicates channel currently undergoing conversion
- **CCFx**: Conversion Complete Flag for each result register



ATD Results Registers

- **ADR_xH**: memory address: \$0070 - 007E eight bytes
 - after conversion, results placed in ADR0H-7H
 - unsigned, weighted binary result
- 1/2FS, 1/4FS, 1/8FS, ..., 1/256FS., FS=full scale
- $V_{DC} = V_{RL} + ([\text{contents ADR}_{xH}] / 256) \times (V_{RH} - V_{RL})$

Register: Analog-to-Digital Converter Result Register 0 (ADR0H)	Address: \$0070
Register: Analog-to-Digital Converter Result Register 1 (ADR1H)	Address: \$0072
Register: Analog-to-Digital Converter Result Register 2 (ADR2H)	Address: \$0074
Register: Analog-to-Digital Converter Result Register 3 (ADR3H)	Address: \$0076
Register: Analog-to-Digital Converter Result Register 4 (ADR4H)	Address: \$0078
Register: Analog-to-Digital Converter Result Register 5 (ADR5H)	Address: \$007A
Register: Analog-to-Digital Converter Result Register 6 (ADR6H)	Address: \$007C
Register: Analog-to-Digital Converter Result Register 7 (ADR7H)	Address: \$007E

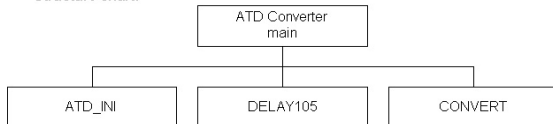
7	6	5	4	3	2	1	0
Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reset: 0	0	0	0	0	0	0	0

Example: If $V_{RH} = 2.2$, $V_{RL} = 0.5$, what analog value is represented by ADR2H = 00110110?

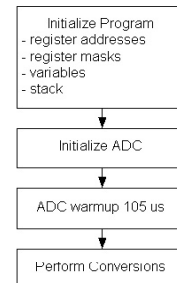


ATD Programming Example

Structure chart:



Flow chart:



```

/* File Name: voltmeter.c
 * File Created: 04-14-02
 * File Modified:
 * Author(s): Abbie Wells
 * Carrie Hernandez, LCD Portions
 */

/* This program will create a simple voltmeter using the onboard
 * analog to digital converter in the HC12. It will perform one
 * conversion and then the user will have to manually restart the
 * program to convert another voltage. The voltage will then be
 * displayed to the LCD.
 */

#include <hc12.h>
#include <stdio.h>

#define DECIMAL 0x2E // define macro for a decimal point in ASCII
#define V 0x56 // define macro for a 'V' in ASCII

void delay_100us(void);
void ADC_convert(void);
void delay_5ms(void);
void main(void)
{
    printf("HELLO\n");
    ATDCTL2 = 0x80; // power up the ADC and disable interrupts
    printf("ADC2\n");
    delay_5ms(); // wait for ADC to warm up
    printf("wared up\n");
    ATDCTL3 = 0x00; // select active background mode
    ATDCTL4 = 0x01; // select sample time = 2 ADC clks and set
    // prescaler to 4 (2 MHz)
    printf("ready\n");
    ADC_convert(); // perform conversion and change to usable
    // value
}
    
```

```

/* void ADC_convert(void): function to perform a single conversion */
void ADC_convert()
{
    unsigned int sumadr;
    unsigned int avg_bin_voltage;
    unsigned int int_voltage;
    unsigned int ones_int;
    unsigned int tenths_int;
    unsigned int hundredths_int;
    char ones;
    char tenths;
    char hundredths;

    ATDCTL5 = 0x03; // sets up ADC to perform a single conversion,
    // 4 conversions on a single channel,
    // and store the results ADR0H - ADR3H.

    while((ATDSTAT & 0x8000) != 0x8000) // Wait for conversion to finish
    {
    };

    //printf("%x %x %x %x\n", ADR0H, ADR1H, ADR2H, ADR3H);
    sumadr = ADR0H + ADR1H + ADR2H + ADR3H;
    avg_bin_voltage = sumadr/4;
    int_voltage = (100*avg_bin_voltage/256)*5;
    ones_int = int_voltage/100;
    ones = (char)ones_int + 48;
    tenths_int = (int_voltage - ones_int*100)/10;
    tenths = (char)tenths_int + 48;
    hundredths_int = (int_voltage - ones_int*100 - tenths_int*10)/1;
    hundredths = (char)hundredths_int + 48;
    printf("%c%c%c\n", ones, tenths, hundredths);
}

.....
/*100us delay based on an 8MHz clock
 *.....
void delay_100us(void)
{
    int i;
    for (i=0; i<400; i++)
    {
        asm("nop");
    }
}
.....
/*5 ms delay based on an 8MHz clock
 *.....
void delay_5ms(void)
{
    int i;
    for (i=0; i<800; i++)
    {
        delay_100us();
    }
}
    
```

